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1 Overview

This document contains information for LM25148 (VQFN package) to aid in a functional safety system design. Information provided are:

- Functional Safety Failure In Time (FIT) rates of the semiconductor component estimated by the application of industry reliability standards
- Component failure modes and their distribution (FMD) based on the primary function of the device
- Pin failure mode analysis (Pin FMA)

Figure 1-1 shows the device functional block diagram for reference.

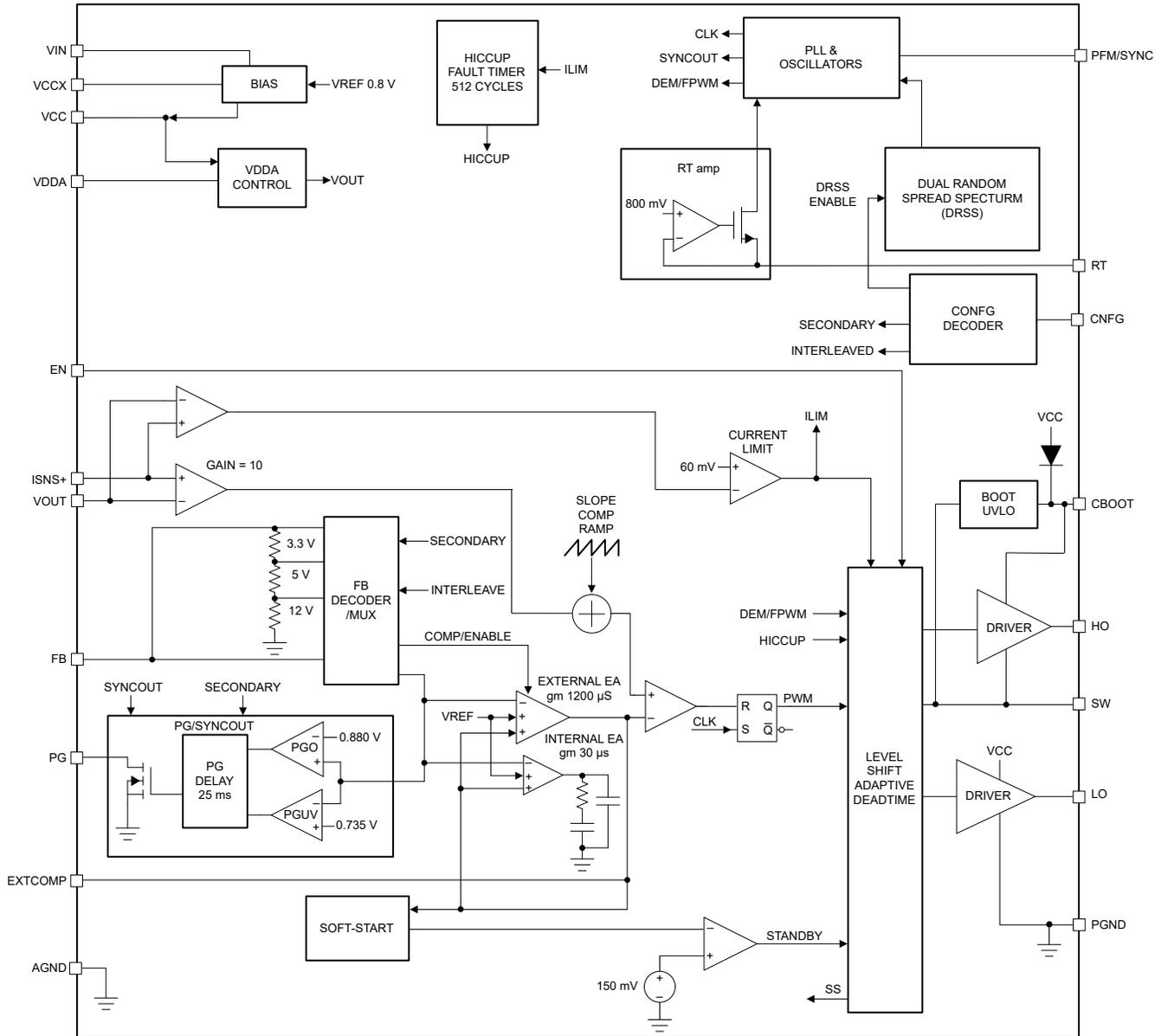


Figure 1-1. Functional Block Diagram

LM25148 was developed using a quality-managed development process, but was not developed in accordance with the IEC 61508 or ISO 26262 standards.

ADVANCE INFORMATION for preproduction products; subject to change without notice.

2 Functional Safety Failure In Time (FIT) Rates

This section provides Functional Safety Failure In Time (FIT) rates for LM25148 based on two different industry-wide used reliability standards:

- [Table 2-1](#) provides FIT rates based on IEC TR 62380 / ISO 26262 part 11
- [Table 2-2](#) provides FIT rates based on the Siemens Norm SN 29500-2

Table 2-1. Component Failure Rates per IEC TR 62380 / ISO 26262 Part 11

FIT IEC TR 62380 / ISO 26262	FIT (Failures Per 10 ⁹ Hours)
Total Component FIT Rate	16
Die FIT Rate	6
Package FIT Rate	10

The failure rate and mission profile information in [Table 2-1](#) comes from the Reliability data handbook IEC TR 62380 / ISO 26262 part 11:

- Mission Profile: Motor Control from Table 11
- Power dissipation: 750 mW
- Climate type: World-wide Table 8
- Package factor (lambda 3): Table 17b
- Substrate Material: FR4
- EOS FIT rate assumed: 0 FIT

Table 2-2. Component Failure Rates per Siemens Norm SN 29500-2

Table	Category	Reference FIT Rate	Reference Virtual T _J
5	CMOS, BICMOS ASICs Analog & mixed HV >50V supply	30 FIT	75°C

The Reference FIT Rate and Reference Virtual T_J (junction temperature) in [Table 2-2](#) come from the Siemens Norm SN 29500-2 tables 1 through 5. Failure rates under operating conditions are calculated from the reference failure rate and virtual junction temperature using conversion information in SN 29500-2 section 4.

3 Failure Mode Distribution (FMD)

The failure mode distribution estimation for LM25148 in [Table 3-1](#) comes from the combination of common failure modes listed in standards such as IEC 61508 and ISO 26262, the ratio of sub-circuit function size and complexity and from best engineering judgment.

The failure modes listed in this section reflect random failure events and do not include failures due to misuse or overstress.

Table 3-1. Die Failure Modes and Distribution

Die Failure Modes	Failure Mode Distribution (%)
No Output Voltage	60%
Output not in specification – voltage or timing	25%
Gate driver stuck on	5%
Power Good - False trip or fails to trip	5%
Short circuit any two pins	5%

The FMD in [Table 3-1](#) excludes short circuit faults across the isolation barrier. Faults for short circuit across the isolation barrier can be excluded according to ISO 61800-5-2:2016 if the following requirements are fulfilled:

1. The signal isolation component is OVC III according to IEC 61800-5-1. If a SELV/PELV power supply is used, pollution degree 2/OVC II applies. All requirements of IEC 61800-5-1:2007, 4.3.6 apply.
2. Measures are taken to ensure that an internal failure of the signal isolation component cannot result in excessive temperature of its insulating material.

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance.

4 Pin Failure Mode Analysis (Pin FMA)

This section provides a Failure Mode Analysis (FMA) for the pins of the LM25148. The failure modes covered in this document include the typical pin-by-pin failure scenarios:

- Pin short-circuited to Ground (see [Table 4-2](#))
- Pin open-circuited (see [Table 4-3](#))
- Pin short-circuited to an adjacent pin (see [Table 4-4](#))
- Pin short-circuited to supply (see [Table 4-5](#))

[Table 4-2](#) through [Table 4-5](#) also indicate how these pin conditions can affect the device as per the failure effects classification in [Table 4-1](#).

Table 4-1. TI Classification of Failure Effects

Class	Failure Effects
A	Potential device damage that affects functionality
B	No device damage, but loss of functionality
C	No device damage, but performance degradation
D	No device damage, no impact to functionality or performance

[Figure 4-1](#) shows the LM25148 pin diagram. For a detailed description of the device pins please refer to the *Pin Configuration and Functions* section in the LM25148 data sheet.

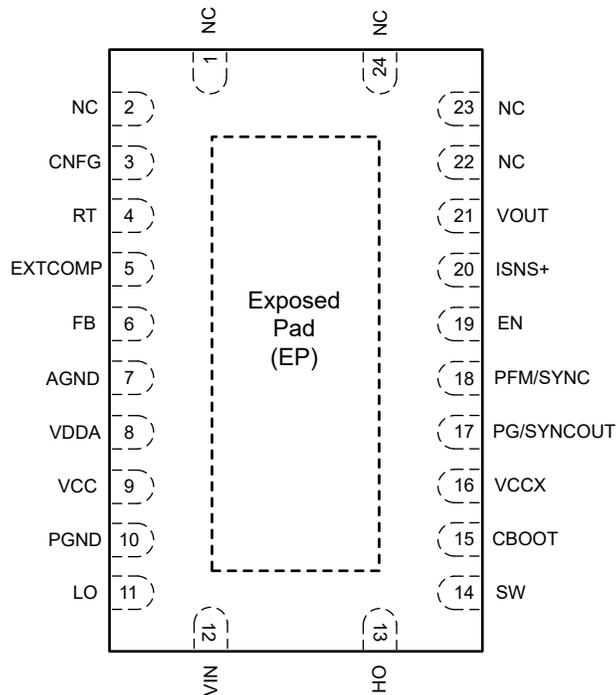


Figure 4-1. Pin Diagram

Following are the assumptions of use and the device configuration assumed for the pin FMA in this section:

- Application Circuit as per the [LM25148 data sheet](#) is used
 - PG is pulled up to V_{OUT}

Table 4-2. Pin FMA for Device Pins Short-Circuited to Ground

Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
NC	1	NC can be connected to Ground for improved heat spreading.	D
NC	2	NC can be connected to Ground for improved heat spreading.	D
CNFG	3	V_{OUT} is unaffected.	C
RT	4	V_{OUT} will attempt to regulate at maximum f_{SW} , causing maximum power dissipation.	B
EXTCOMP	5	$V_{OUT} = 0\text{ V}$	B
FB	6	Internal FB mode, $V_{OUT} = \text{expected } V_{OUT}$	D
		External FB mode, $V_{OUT} = V_{IN}$	A
AGND	7	AGND is GND. $V_{OUT} = \text{expected } V_{OUT}$	D
VDDA	8	$V_{OUT} = 0\text{ V}$, no switching, loaded VCC output	B
VCC	9	$V_{OUT} = 0\text{ V}$, no switching, loaded VCC output	B
PGND	10	PGND is GND. $V_{OUT} = \text{expected } V_{OUT}$	D
LO	11	$V_{OUT} = 0\text{ V}$, the VCC regulator loaded to current limit.	B
V_{IN}	12	$V_{OUT} = 0\text{ V}$	B
HO	13	$V_{OUT} = 0\text{ V}$, the VCC regulator loaded to current limit.	B
SW	14	$V_{OUT} = 0\text{ V}$. High-side FET is shorted from V_{IN} to GND.	A
CBOOT	15	$V_{OUT} = 0\text{ V}$, the VCC regulator loaded to current limit.	B
VCCX	16	$V_{OUT} = \text{expected } V_{OUT}$. Internal VCC regulator provides bias voltage.	C
PG	17	If in single phase, PG has no effect on operation. $V_{OUT} = \text{expected } V_{OUT}$	C
		If in interleaved primary mode, the secondary will detect no clock input and will shut down. Secondary phase is disabled and primary phase can current limit.	B
PFM/SYNC	18	$V_{OUT} = \text{expected } V_{OUT}$. No synchronization will be available and LM25148 will be in FPWM mode.	C
EN	19	$V_{OUT} = 0\text{ V}$, the LM25148 enters shutdown.	C
ISNS+	20	$V_{OUT} = 0\text{ V}$, HO damaged	A
V_{OUT}	21	$V_{OUT} = 0\text{ V}$. Current limit reached, hiccup mode occurs.	B
NC	22	NC can be connected to Ground for improved heat spreading.	D
NC	23	NC can be connected to Ground for improved heat spreading.	D
NC	24	NC can be connected to Ground for improved heat spreading.	D

Table 4-3. Pin FMA for Device Pins Open-Circuited

Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
NC	1	NC can be open-circuited.	D
NC	2	NC can be open-circuited.	D
CNFG	3	V_{OUT} will continue operating normally. CNFG is used during start-up.	C
RT	4	RT will regulate to 500 mV, but the internal oscillator will not function.	B
EXTCOMP	5	V_{OUT} will oscillate. If V_{OUT} oscillates to V_{IN} , damage can occur if $V_{IN} > 36$ V.	A
FB	6	Internal FB mode, $V_{OUT} = \text{expected } V_{OUT}$	D
		External FB mode, $V_{OUT} = V_{IN}$	A
AGND	7	V_{OUT} is indeterminate.	B
VDDA	8	Poor noise immunity	C
VCC	9	$V_{OUT} = 0$ V	B
PGND	10	$V_{OUT} = 0$ V	B
LO	11	$V_{OUT} = \text{expected } V_{OUT}$ with reduced efficiency.	C
V_{IN}	12	$V_{OUT} = 0$ V	C
HO	13	If HO is opened while HO to SW has voltage, the high-side FET will never turn off. $V_{OUT} = V_{IN}$	A
SW	14	V_{OUT} is indeterminate. The CBOOT floating rail has no reference to the actual SW node. $V_{OUT} = V_{IN}$	A
CBOOT	15	$V_{OUT} = 0$ V	B
VCCX	16	VCCX held to ground by weak pulldown, $V_{OUT} = \text{expected } V_{OUT}$	D
PG	17	If in single phase, PG has no effect on operation. $V_{OUT} = \text{expected } V_{OUT}$	C
		If in interleaved primary mode, the secondary will detect no clock input and will shut down. Secondary phase is disabled and primary phase can current limit.	B
PFM/SYNC	18	$V_{OUT} = \text{expected } V_{OUT}$	D
EN	19	$V_{OUT} = \text{expected } V_{OUT}$	D
ISNS+	20	The OPEN ISNS+ pin will block current limit and cause V_{OUT} oscillations.	A
V_{OUT}	21	$V_{OUT} = 0$ V	B
NC	22	NC can be open-circuited.	D
NC	23	NC can be open-circuited.	D
NC	24	NC can be open-circuited.	D

Table 4-4. Pin FMA for Device Pins Short-Circuited to Adjacent Pin

Pin Name	Pin No.	Shorted to	Description of Potential Failure Effect(s)	Failure Effect Class
NC	1	NC	No impact	D
NC	2	CNFG	No impact	D
CNFG	3	RT	V_{OUT} = expected V_{OUT} with erratic switching	B
RT	4	EXTCOMP	COMP cannot regulate down due to clamping by internal RT.	B
EXTCOMP	5	FB	External FB mode: COMP will regulate to 0.8 V and output will be unregulated. V_{OUT} = indeterminate	B
			Internal FB mode: COMP will rise up to VDDA. $V_{OUT} = V_{IN}$	A
FB	6	AGND	External FB mode: $V_{OUT} = V_{IN}$	A
			Internal FB mode: V_{OUT} = expected V_{OUT}	D
AGND	7	VDDA	VDDA will be grounded. $V_{OUT} = 0$ V	B
VDDA	8	VCC	V_{OUT} = expected V_{OUT}	D
VCC	9	PGND	VCC will be grounded. $V_{OUT} = 0$ V	B
PGND	10	LO	$V_{OUT} = 0$ V. VCC is loaded by the LO driver.	B
LO	11	V_{IN}	$V_{OUT} = 0$ V. The driver will be damaged if $V_{IN} > 6.5$ V.	A
V_{IN}	12	HO	$V_{OUT} = V_{IN}$	A
HO	13	SW	$V_{OUT} = 0$ V	B
SW	14	CBOOT	$V_{OUT} = 0$ V	B
CBOOT	15	VCCX	$V_{OUT} < 5$ V	A
VCCX	16	PG	PG pulldown can damage, V_{OUT} = expected V_{OUT}	A
PG	17	PFM/SYNC	V_{OUT} = expected V_{OUT}	C
PFM/SYNC	18	EN	V_{OUT} = expected V_{OUT}	A
EN	19	ISNS+	EN is high-voltage rated. V_{OUT} = expected V_{OUT} if $V_{OUT} > 1$ V. If $V_{OUT} < 1$ V, the device is disabled.	B
ISNS+	20	V_{OUT}	Current limit is disabled since the current limit resistor would be shorted. V_{OUT} cannot regulate since current mode feedback is shorted.	A
V_{OUT}	21	NC	No impact	D
NC	22	NC	No impact	D
NC	23	NC	No impact	D
NC	24	NC	No impact	D

Table 4-5. Pin FMA for Device Pins Short-Circuited to V_{IN}

Pin Name	Pin No.	Description of Potential Failure Effect(s)	Failure Effect Class
NC	1	No impact	D
NC	2	No impact	D
CNFG	3	$V_{OUT} = V_{IN}$	A
RT	4	$V_{OUT} = 0$ V, high V_{IN} current	A
EXTCOMP	5	This will bring VDDA up to V_{IN} . $V_{OUT} = V_{IN}$	A
FB	6	This will bring VDDA up to V_{IN} . $V_{OUT} = V_{IN}$	A
AGND	7	$V_{OUT} = V_{IN}$, high V_{IN} current	A
VDDA	8	If $V_{IN} < 6.5$ V, $V_{OUT} =$ expected V_{OUT}	D
		If $V_{IN} > 6.5$ V, exceeds maximum ratings and VDDA is damaged.	A
VCC	9	If $V_{IN} < 6.5$ V, $V_{OUT} =$ expected V_{OUT}	D
		If $V_{IN} > 6.5$ V, exceeds maximum ratings and VCC is damaged.	A
PGND	10	$V_{OUT} = V_{IN}$, high V_{IN} current	A
LO	11	For $V_{IN} < 6.5$ V, $V_{OUT} = 0$; excess current from V_{IN}	B
		For $V_{IN} > 6.5$ V, exceeds maximum ratings and the LO pin is damaged.	A
V_{IN}	12	N/A	D
HO	13	For $V_{IN} < 6.5$ V, $V_{OUT} =$ dropout lower than V_{IN} , no switching, and excess current from V_{IN}	B
		For $V_{IN} > 6.5$ V, exceeds maximum ratings and the HO pin is damaged, $V_{OUT} = V_{IN}$	A
SW	14	$V_{OUT} = V_{IN}$, excess current from V_{IN} . LO turns on and shorts against V_{IN} .	A
CBOOT	15	For $V_{IN} < 6.5$ V, $V_{OUT} =$ expected V_{OUT} , erratic switching	B
		For $V_{IN} > 6.5$ V, exceeds maximum ratings and the CBOOT pin is damaged, HO damaged. $V_{OUT} = V_{IN}$	A
VCCX	16	If $VCCX = V_{OUT}$, for $V_{IN} < 6.5$ V, $V_{OUT} = V_{IN}$	B
		For $V_{IN} > 6.5$ V, exceeds maximum ratings and the VCCX pin is damaged.	A
PG	17	For $V_{IN} < 6.5$ V, $V_{OUT} =$ regulated and PG forced high	B
		For $V_{IN} > 6.5$ V, exceeds maximum ratings and PG is destroyed.	A
PFM/SYNC	18	If PFM = GND, $V_{OUT}=0$ V, excess current from V_{IN}	B
		If PFM = VDDA and $V_{IN} < 6.5$ V, $V_{OUT} =$ expected V_{OUT} . Erratic switching	B
		If $V_{IN} > 6.5$ V, exceeds maximum ratings and the PFM/SYNC pin is damaged, $V_{OUT} =$ expected V_{OUT}	A
EN	19	The LM25148 will be always on. $V_{OUT} =$ expected V_{OUT}	C
ISNS+	20	If $V_{IN} < 36$ V, $V_{OUT} = V_{IN}$	B
		If $V_{IN} > 36$ V, exceeds maximum ratings and the CS pin is damaged.	A
V_{OUT}	21	If $V_{IN} < 36$ V, $V_{OUT} = V_{IN}$	B
		If $V_{IN} > 36$ V, exceeds maximum ratings and the CS pin is damaged.	A
NC	22	No impact	D
NC	23	No impact	D
NC	24	No impact	D

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